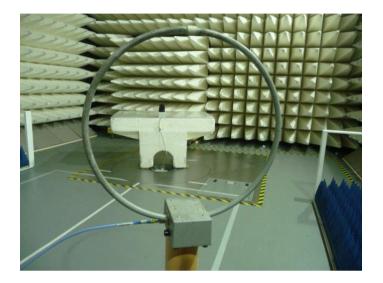
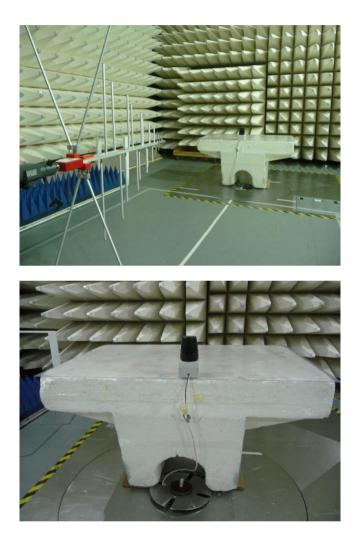
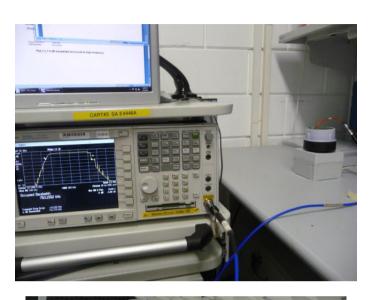


Photograph No.1 Setup for spurious emission measurements in the anechoic chamber below 30 MHz



## Photograph No.2 Setup for carrier field strength and spurious emission measurements in the anechoic chamber below 1000 MHz





Photograph No.3 Setup for OBW, band edge emission and peak power density measurements



## Photograph No.4 Setup for spurious emission measurements in the anechoic chamber above 1000 MHz

